Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,575	DAVIS, PHILIP
Examiner	Art Unit
Anthony Fick	1753

SEARCHED				
Class	Subclass	Date	Examiner	
136	205	12/15/2006	ADF	
136	200-242	12/15/2006	ADF	
134	Ja 140	5/10/07	ADF	
135 updated	265 265	Stefor	ADF	
7				
			•	
	•			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Sec EAS	senah pelsuch)	5/10/01	ADF

SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
See EAST search history	12/15/2006	ADF
Inventor search	12/15/2006	ADF
Consulted with Jeffrey Barton and Nam Nguyen	12/18/2006	ADF
Google scholar search for inventor and keywords	12/15/2006	ADF